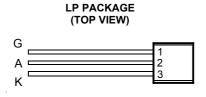
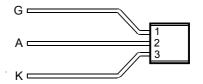
- 1 A Continuous On-State Current
- 15 A Surge-Current
- Glass Passivated Wafer
- 400 V to 600 V Off-State Voltage
- I_{GT} 50 μA min, 200 μA max
- di/dt 100A/μs
- Package Options

PACKAGE	PACKING	PART # SUFFIX		
LP	Bulk	(None)		
LP with fomed leads	Tape and Reel	R		



MDC1AA

LP PACKAGE WITH FORMED LEADS (TOP VIEW)



MDC1AB

absolute maximum ratings over operating junction temperature (unless otherwise noted)

RATING	SYMBOL	VALUE	UNIT	
Repetitive peak off-state voltage (see Note 1)	TICP107D	V	400	V
hepetitive peak oif-state voitage (see Note 1)	TICP107M	V_{DRM}	600	
epetitive peak reverse voltage	TICP107D	V	400	٧
hepetitive peak reverse voltage	TICP107M	V_{RRM}	600	
Continuous on-state current at (or below) 25°C ambient temperature (see Note 2	I _{T(RMS)}	1	Α	
Surge on-state current at (or below) 25°C ambient temperature (see Note 3)			15	Α
Critical rate of rise of on-state current at 110°C (see Note 4)	di/dt	100	A/µs	
Peak positive gate current (pulse width ≤ 300 μs)	I _{GM}	0.2	Α	
Junction temperature range	T _J	-40 to +110	°C	
Storage temperature range	T _{stg}	-40 to +125	°C	
Lead temperature 3.2 mm from case for 10 seconds			230	°C

NOTES: 1. These values apply when the gate-cathode resistance R_{GK} = 1 $k\Omega$

- 2. These values apply for continuous dc operation with resistive load.
- 3. This value applies for one 50 Hz half-sine-wave when the device is operating at (or below) the rated value of peak reverse voltage and on-state current. Surge may be repeated after the device has returned to original thermal equilibrium.
- 4. Rate of rise of on-state current after triggering with $I_G = 10$ mA, $di_G/dt = 1$ A/ μ s.



TICP107 SERIES SILICON CONTROLLED RECTIFIERS

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electrical characteristics at 25°C ambient temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
I _{DRM}	Repetitive peak	V_D = rated V_{DRM}	R _{GK} = 1 kΩ				20	μΑ
, DKIM	off-state current							μ., .
	Repetitive peak	V _B = rated V _{BBM}	I _G = 0				200	μА
IRRM	m reverse current v _R = rated v _{RRM}	VR - rated VRRM				200	μΛ	
I _{GT}	Gate trigger current	V _{AA} = 12 V	$R_L = 100 \Omega$	t _{p(g)} ≥ 20 μs	50		200	μΑ
V_{GT}	Gate trigger voltage	V _{AA} = 12 V	$R_L = 100 \Omega$	t _{p(g)} ≥ 20 μs	0.4		1	V
I _H	Holding current	V _{AA} = 12 V		Initiating I _T = 10 mA			2	mA
V _T	On-state voltage	I _T = 2 A	(see Note 5)				1.4	V

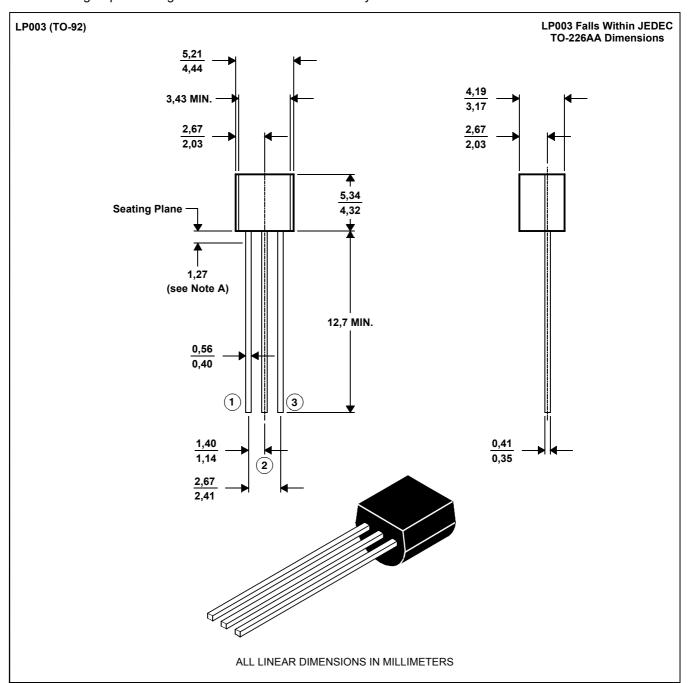
NOTE 5: This parameter must be measured using pulse techniques, t_p = 1 ms, duty cycle ≤ 2 %. Voltage sensing-contacts, separate from the current carrying contacts, are located within 3.2 mm from the device body.

MECHANICAL DATA

LP003 (TO-92)

3-pin cylindical plastic package

This single-in-line package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions. Leads require no additional cleaning or processing when used in soldered assembly.



NOTE A: Lead dimensions are not controlled in this area.

MDXXAX



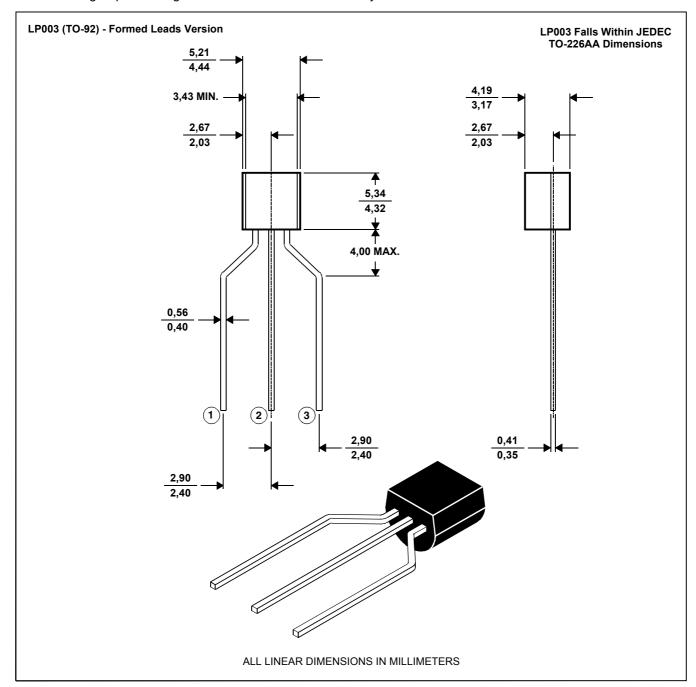
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MECHANICAL DATA

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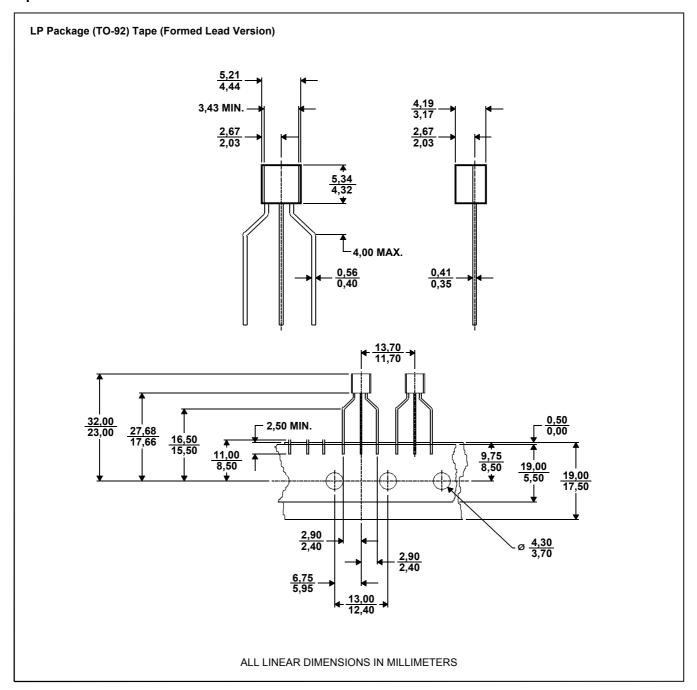


MDXXAR

PRODUCT INFORMATION

MECHANICAL DATA

LPR tape dimensions



MDXXAS



TICP107 SERIES SILICON CONTROLLED RECTIFIERS

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